FCC Part 15B **Measurement and Test Report**

For

SUPERDIGITAL TECHNOLOGY CO., LIMITED

19th Floor, Block B, Nanxian Building, Longhua New District, Shenzhen 518000, P.R. China

FCC ID: 2ACDFX20

Test Rule(s): FCC Part 15 Subpart B

Product Description: Mobile Phone

Tested Model: X20

Report No.: STR15048006I-3

Tested Date: 2015-04-01 to 2015-04-16

Issued Date: 2015-04-17

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Note: This test report is limited to the above client company and the product model only. It may not be duplicated without prior permitted by Shenzhen SEM.Test Technology Co., Ltd.

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1. GENERAL INFORMATION

1.1 Product Description for Equipment Under Test (EUT)

Client Information

Applicant: SUPERDIGITAL TECHNOLOGY CO., LIMITED

Address of applicant: 19th Floor, Block B, Nanxian Building, Longhua New

District, Shenzhen 518000, P.R. China

Manufacturer: SUPERDIGITAL TECHNOLOGY CO., LIMITED

Address of manufacturer: 19th Floor, Block B, Nanxian Building, Longhua New

District, Shenzhen 518000, P.R. China

Mobile Phone
Superinworld
X20
1

The EUT is GSM850/900/DCS1800/PCS1900 Mobile phone. The Mobile phone is intended for speech and Multimedia Message Service (MMS) transmission. It is equipped with GPRS class 12 for GSM850 and GSM1900 and Bluetooth, camera functions. For more information see the following datasheet

Note: The test data is gathered from a production sample provided by the manufacturer.

Technical Characteristics of EUT				
Rated Voltage:	3.7V			
Rated Current:	850mA			
Rated Power:	/			
Lowest Internal Frequency:	26MHz			
Highest Internal Frequency:	26MHz			
Classification of ITE:	Class B			

1.2 Test Standards

The following report is prepared on behalf of the SUPERDIGITAL TECHNOLOGY CO., LIMITED in accordance with Part 2, Subpart J, and Part 15, Subparts A and B of the Federal Communication Commissions rules

The objective is to determine compliance with FCC Part 15, Subpart B, and section 15.205, 15.107, and 15.109 rules.

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product, which result in lowering the emission, should be checked to ensure compliance has been maintained.

1.3 Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2003, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

1.4 Test Facility

• FCC – Registration No.: 934118

Shenzhen SEM.Test Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files and the Registration is 934118.

• Industry Canada (IC) Registration No.: 11464A

The 3m Semi-anechoic chamber of Shenzhen SEM.Test Technology Co., Ltd. Has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 11464A.

• CNAS Registration No.: L4062

Shenzhen SEM.Test Technology Co., Ltd. Is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L4062. All measurement facilities used to collect the measurement data are located at 1/F, Building A, Hongwei Industrial Park, Liuxian 2nd Road, Bao'an District, Shenzhen, P.R.C (518101)

1.5 EUT Setup and Operation Mode

The equipment under test (EUT) was configured to measure its highest possible emission level. The test modes were adapted according to the operation manual for use, more detailed description as follows:

Test Mode List:

Test Mode Description		Remark		
TM1 Charging & Playing & Camera		Connect to Adapter		
TM2	Downloading	Connect to PC		

EUT Cable List and Details

Cable Description	Length (M)	Shielded/Unshielded	With Core/Without Core	
Earphone	0.8	Unshielded	Without Ferrite	

Auxiliary Equipment List and Details

Description	Manufacturer	Model	Serial Number
Notebook	Lenovo	E10	LR-63C8R
Adapter	/	ETA-U90	/

Special Cable List and Details

Cable Description	Length (M) Shielded/Unshielded		With Core/Without Core	
USB Cable	1.0	Shielded	Without Core	

2. SUMMARY OF TEST RESULTS

FCC Rules	Description of Test Item	Result
§ 15.107 (a)	Conducted Emissions	Compliant
§ 15.109 (a)	Radiated Emissions	Compliant

N/A: not applicable

3. Conducted Emissions

3.1 Measurement Uncertainty

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any conducted emissions measurement is \pm 2.88 dB.

3.2 Test Equipment List and Details

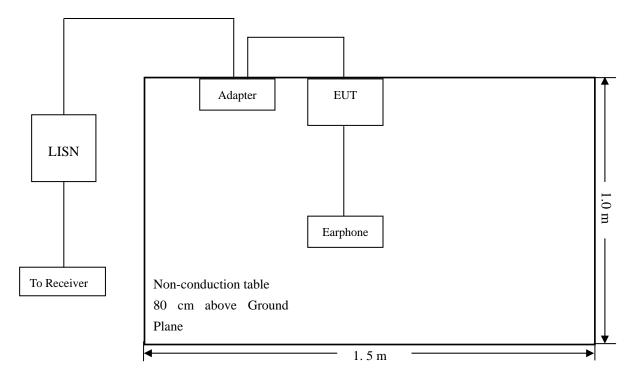
Description	Manufacturer	Model	Serial Number	Cal. Date	Due. Date
EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2014-05-28	2015-05-27
L.I.S.N	Schwarz beck	NSLK8126	8126-224	2014-05-28	2015-05-27
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2014-05-28	2015-05-27

3.3 Test Procedure

Test is conducting under the description of ANSI C63.4-2003, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

Note: Base on the calibrated result, for the impedance characteristic and insertion loss, the effect shall be ignored from the placed multiple outlet power strip between the device and LISN.

3.4 Basic Test Setup Block Diagram



3.5 Environmental Conditions

Temperature:	23 °C
Relative Humidity:	52%
ATM Pressure:	1011 mbar

3.6 Summary of Test Results/Plots

According to the data in section 3.7, the EUT <u>complied with the FCC Part 15.107(a)</u> Conducted margin for a Class B device, with the *worst* margin reading of:

-3.42 dB at 0.5220 MHz in the Neutral mode, AVG detector, 0.15-30MHz

3.7 Conducted Emissions Test Data

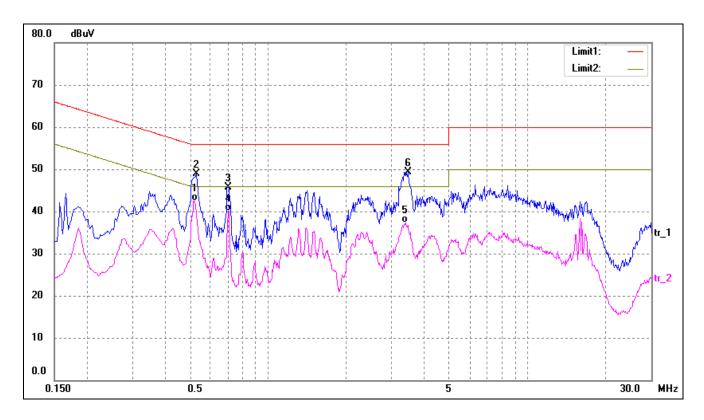
Plot of Conducted Emissions Test Data

EUT: Mobile Phone

Tested Model: X20 Operating Conditaion: TM1

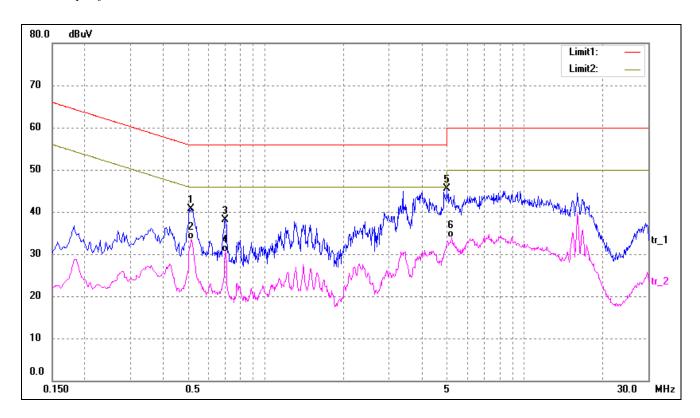
Comment: AC 120V/60Hz,Adapter DC 5V/0.5A

Test Specification: Neutral



No.	Frequency	Reading	Correct	Result	Limit	Margin	Detector
	(MHz)	(dBuV)	(dB/m)	(dBuV)	(dBuV)	(dB)	
1*	0.5220	33.06	9.52	42.58	46.00	-3.42	AVG
2	0.5300	39.33	9.53	48.86	56.00	-7.14	peak
3	0.7020	36.01	9.70	45.71	56.00	-10.29	peak
4	0.7060	30.31	9.71	40.02	46.00	-5.98	AVG
5	3.3820	27.25	10.00	37.25	46.00	-8.75	AVG
6	3.4580	39.34	10.00	49.34	56.00	-6.66	peak

Test Specification: Line



No.	Frequency	Reading	Correct	Result	Limit	Margin	Detector
	(MHz)	(dBuV)	(dB/m)	(dBuV)	(dBuV)	(dB)	
1	0.5180	31.27	9.52	40.79	56.00	-15.21	peak
2*	0.5180	23.90	9.52	33.42	46.00	-12.58	AVG
3	0.6980	28.37	9.70	38.07	56.00	-17.93	peak
4	0.6980	20.82	9.70	30.52	46.00	-15.48	AVG
5	5.0260	35.42	10.00	45.42	60.00	-14.58	peak
6	5.2460	23.81	10.00	33.81	50.00	-16.19	AVG

4. Radiated Emissions

4.1 Measurement Uncertainty

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any radiation emissions measurement is \pm 5.10 dB.

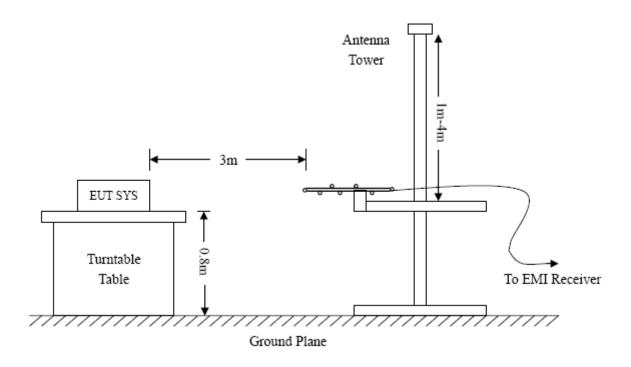
4.2 Test Equipment List and Details

Description	scription Manufacturer		Serial Number	Cal. Date	Due. Date
Spectrum Analyzer	R&S	FSP	836079/035	2014-05-28	2015-05-27
EMI Test Receiver	R&S	ESVB	825471/005	2014-05-28	2015-05-27
Pre-amplifier	Agilent	8447F	3113A06717	2014-05-28	2015-05-27
Pre-amplifier	Compliance Direction	PAP-0118	24002	2014-05-28	2015-05-27
Trilog Broadband Antenna	SCHWARZBECK	VULB9163	9163-333	2014-05-24	2015-05-23
Horn Antenna	ETS	3117	00086197	2014-05-24	2015-05-23
Loop Antenna	SCHWARZECK	HFRA 5165	9365	2014-05-28	2015-05-27

4.3 Test Procedure

The setup of EUT is according with per ANSI C63.4-2003 measurement procedure. The specification used was with the FCC Part 15.109 Limit.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle. The spacing between the peripherals was 10 cm.



4.4 Test Receiver Setup

Frequency:9kHz-30MHz Frequency:30MHz-1GHz Frequency:Above 1GHz

RBW=10KHz, RBW=120KHz, RBW=1MHz,

VBW=30KHz VBW=300KHz VBW=3MHz(Peak), 10Hz(AV)

Sweep time= Auto Sweep time= Auto Sweep time= Auto
Trace = max hold Trace = max hold Trace = max hold

Detector function = peak, QP Detector function = peak, AV

4.5 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

Corr. Ampl. = Indicated Reading - Corr. Factor

The "Margin" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of $-6dB\mu V$ means the emission is $6dB\mu V$ below the maximum limit for a Class B device. The equation for margin calculation is as follows:

Margin = Corr. Ampl. – FCC Part 15.109(a) Limit

4.6 Environmental Conditions

Temperature:	23 °C
Relative Humidity:	55 %
ATM Pressure:	1011 mbar

4.7 Summary of Test Results/Plots

According to the data, the EUT complied with the FCC Part 15.109(a) rule, and had the worst margin of:

-3.58 dB at 519.9282 MHz in the Horizontal polarization, TM1 mode, 9 kHz to 6 GHz, 3Meters

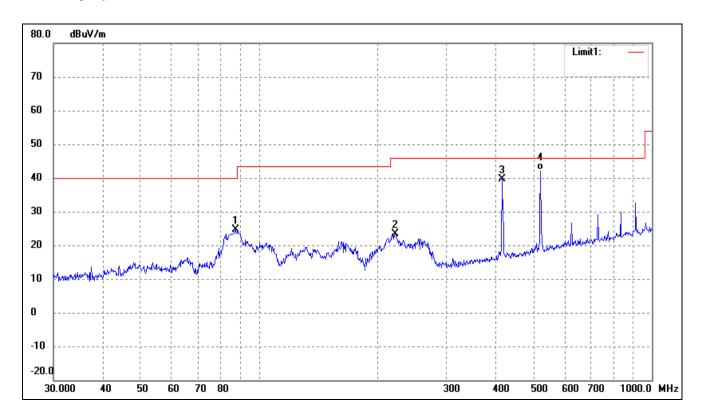
Plot of Radiated Emissions Test Data

EUT: Mobile Phone

Tested Model: X20 Operating Condition: TM1

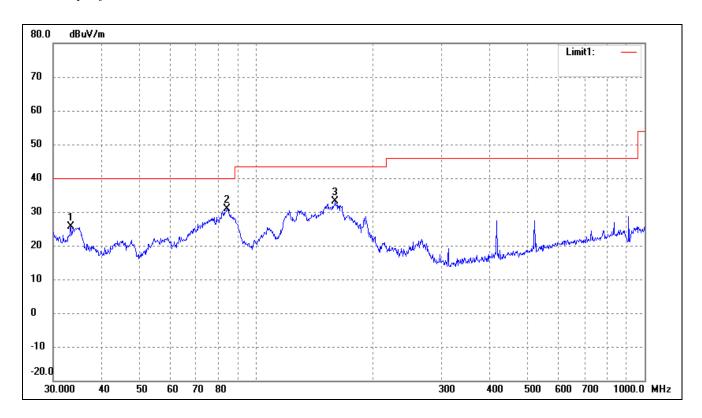
Comment: AC 120V/60Hz,Adapter DC 5V/0.5A

Test Specification: Horizontal



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV/m)	dB/m	(dBuV/m)	(dBuV/m)	(dB)	()	(cm)	
1	87.1117	36.40	-11.75	24.65	40.00	-15.35			peak
2	222.1698	33.06	-9.58	23.48	46.00	-22.52			peak
3	416.1791	44.04	-4.47	39.57	46.00	-6.43			peak
4	519.9282	45.04	-2.62	42.42	46.00	-3.58	100	0	QP

Test Specification: Vertical



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV/m)	dB/m	(dBuV/m)	(dBuV/m)	(dB)	()	(cm)	
1	33.3279	35.88	-10.36	25.52	40.00	-14.48			peak
2	84.1100	42.72	-11.83	30.89	40.00	-9.11			peak
3	159.7844	46.14	-13.07	33.07	43.50	-10.43			peak

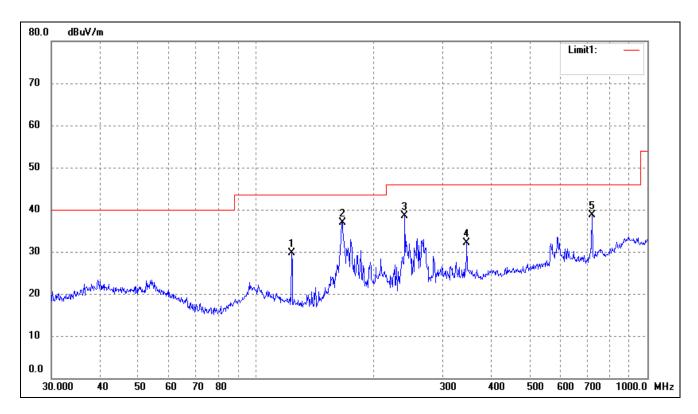
Plot of Radiated Emissions Test Data

EUT: Mobile Phone

Tested Model: X20 Operating Condition: TM2

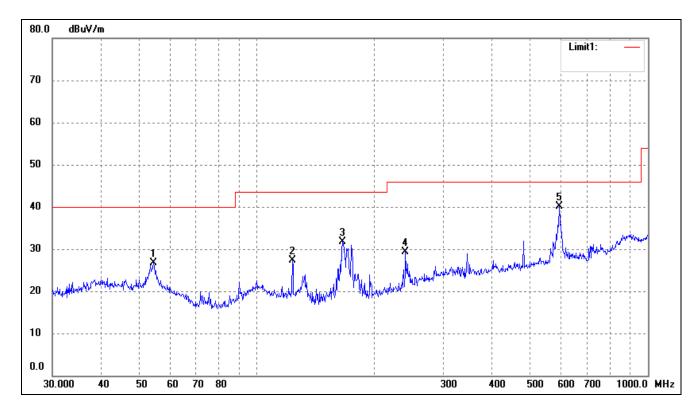
Comment: AC 120V/60Hz, USB DC 5V

Test Specification: Horizontal



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV/m)	dB/m	(dBuV/m)	(dBuV/m)	(dB)	()	(cm)	
1	123.2655	25.96	3.76	29.72	43.50	-13.78	32	100	peak
2	166.0680	34.27	2.65	36.92	43.50	-6.58	32	100	peak
3	239.9874	32.11	6.33	38.44	46.00	-7.56	32	100	peak
4	345.5952	23.29	8.87	32.16	46.00	-13.84	32	100	peak
5	721.7259	26.28	12.47	38.75	46.00	-7.25	32	100	peak

Test Specification: Vertical



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV/m)	dB/m	(dBuV/m)	(dBuV/m)	(dB)	()	(cm)	
1	54.4516	20.93	5.87	26.80	40.00	-13.20	14	100	peak
2	123.2655	23.52	3.76	27.28	43.50	-16.22	14	100	peak
3	165.4867	29.11	2.65	31.76	43.50	-11.74	14	100	peak
4	239.9874	22.89	6.33	29.22	46.00	-16.78	14	100	peak
5	593.0497	27.14	13.06	40.20	46.00	-5.80	14	100	peak

Note: Testing is carried out with frequency rang 9kHz to the 6GHz, which above 1GHz is close to the noise base even antenna close up to 1meter distance according the measurement of ANSI C63.4.

The measurements greater than 20dB below the limit from 9kHz to 30MHz and test data are not provided.

***** END OF REPORT *****